

# HN2E02F

Super High Speed Switching Application  
 Audio Frequency Amplifier Application  
 AM Amplifier Application

Unit: mm

**Q1**

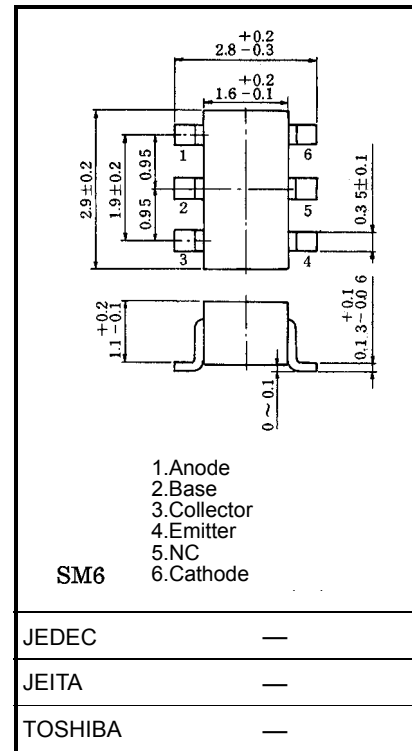
Low Forward Voltage Drop :  $V_{F(3)}=0.98V(\text{typ.})$   
 Fast Reverse Recovery Time :  $t_{rr}=1.6ns(\text{typ.})$   
 Low Total Capacitance :  $C_T=0.5pF(\text{typ.})$

**Q2**

High Voltage :  $V_{CEO}=50V$   
 High Collector Current :  $I_C=150mA(\text{max.})$

Good  $h_{FE}$  Linearity  
 :  $h_{FE}(I_C=0.1mA) / h_{FE}(I_C=2mA) = 0.95$

Q1(Diode) : 1SS352 Equivalent  
 Q2(Transistor) : 2SC4738 Equivalent



**Q1(Diode) Maximum Ratings (Ta = 25°C)**

Characteristic	Symbol	Rating	Unit
Maximum (peak) reverse voltage	$V_{RM}$	85	V
Reverse voltage	$V_R$	80	V
Maximum (peak) forward current	$I_{FM}$	300	mA
Average forward current	$I_O$	100	mA
Surge current (10ms)	$I_{FSM}$	1	A

Weight:0.015g (typ.)

**Q2(Transistor) Maximum Ratings (Ta = 25°C)**

Characteristic	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	60	V
Collector-emitter voltage	$V_{CEO}$	50	V
Emitter-base voltage	$V_{EBO}$	5	V
Collector current	$I_C$	150	mA
Base current	$I_B$	30	mA

**Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)**

Characteristic	Symbol	Rating	Unit
Collector power dissipation	$P_C^*$	300	mW
Junction temperature	$T_j$	125	°C
Storage temperature range	$T_{stg}$	-55~125	°C

\* Total rating. 200mW per 1 element must not be exceeded.

## Q1(Diode) Electrical Characteristics (Ta = 25°C)

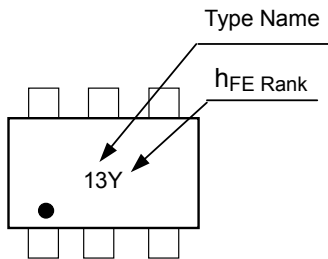
Characteristic	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Forward voltage	$V_F(1)$	—	$I_F = 1\text{mA}$	—	0.62	—	V
	$V_F(2)$	—	$I_F = 10\text{mA}$	—	0.75	—	
	$V_F(3)$	—	$I_F = 100\text{mA}$	—	0.98	1.2	
Reverse current	$I_R(1)$	—	$V_R = 30\text{V}$	—	—	0.1	$\mu\text{A}$
	$I_R(2)$	—	$V_R = 80\text{V}$	—	—	0.5	
Total capacitance	$C_T$	—	$V_R = 0, f = 1\text{MHz}$	—	0.5	—	pF
Reverse recovery time	$t_{rr}$	—	$I_F = 10\text{mA}$ (fig.1)	—	1.6	—	ns

## Q2(Transistor) Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	$I_{CBO}$	—	$V_{CB} = 60\text{V}, I_E = 0$	—	—	100	nA
Emitter cut-off current	$I_{EBO}$	—	$V_{EB} = 5\text{V}, I_C = 0$	—	—	100	nA
DC current gain	$h_{FE}^*$	—	$V_{CE} = 6\text{V}, I_C = 2\text{mA}$	120	—	700	
Collector-emittersaturation voltage	$V_{CE(sat)}$	—	$I_C = 100\text{mA}, I_B = 10\text{mA}$	—	0.1	0.25	V
Transition Frequency	$f_T$	—	$V_{CE} = 10\text{V}, I_C = 10\text{mA}$	60	—	—	MHz
Collector Output Capacitance	$C_{ob}$	—	$V_{CB} = 10\text{V}, I_E = 0, f = 1\text{MHz}$	—	2.0	—	pF

\*  $h_{FE}$  Rank Y(Y) : 120~240, GR(G) : 200~400, BL(L) : 350~700 ( ) Marking Symbol

### Marking



### Equivalent Circuit (Top View)

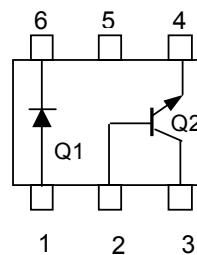
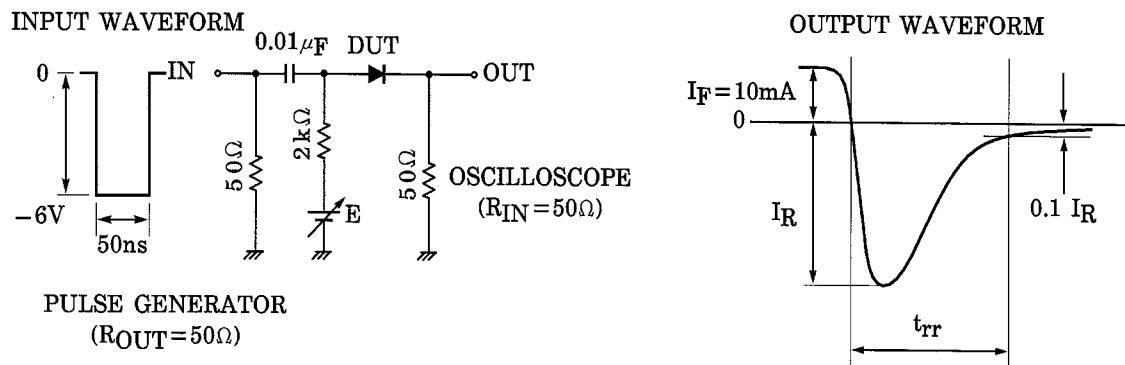
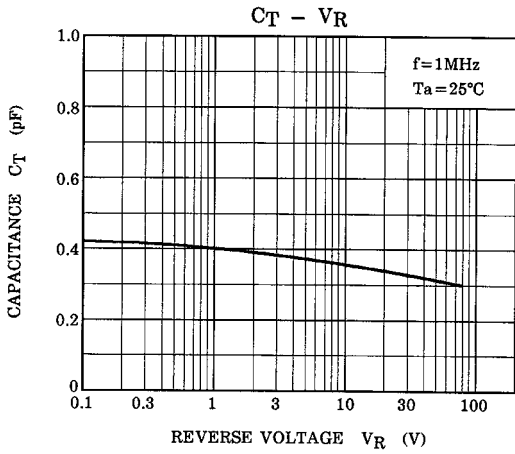
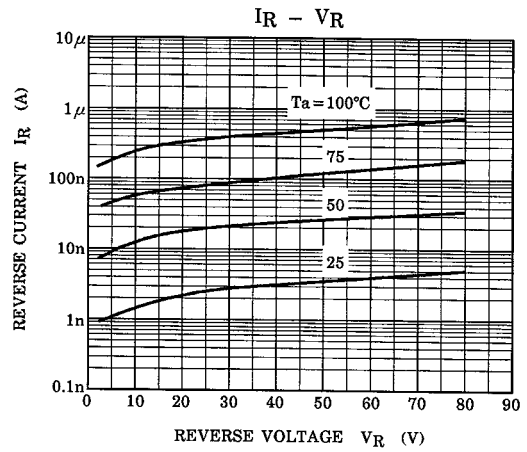
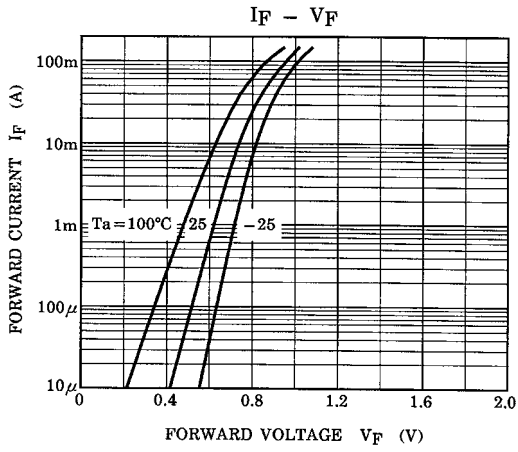


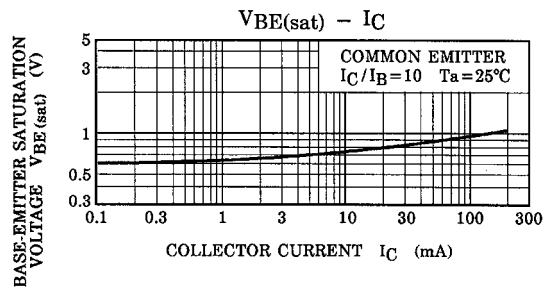
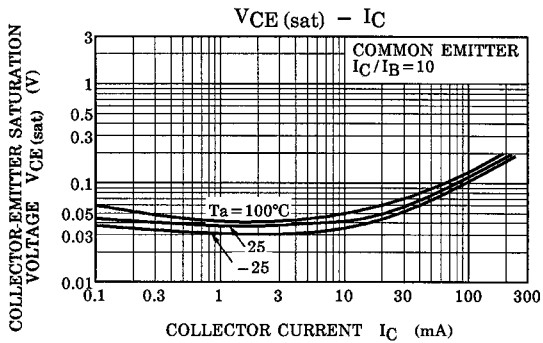
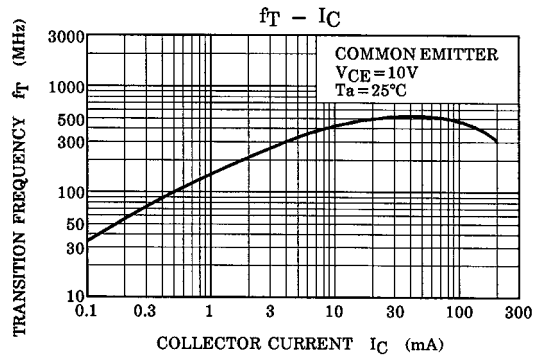
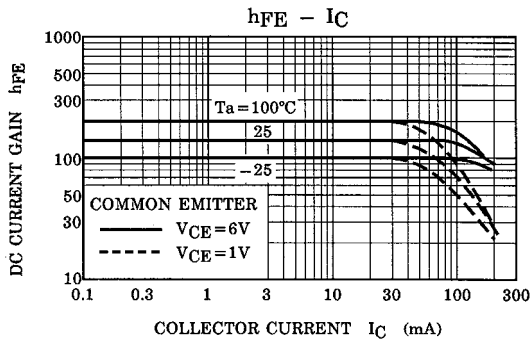
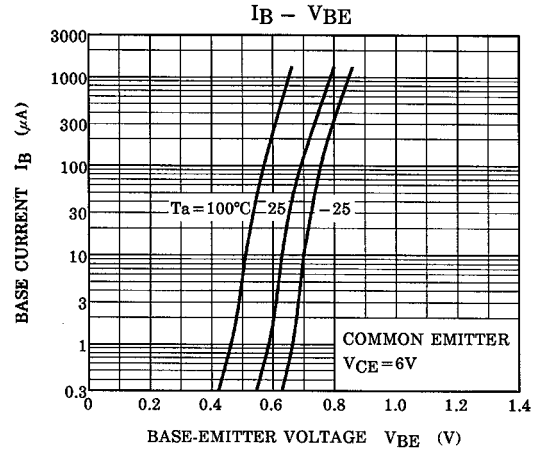
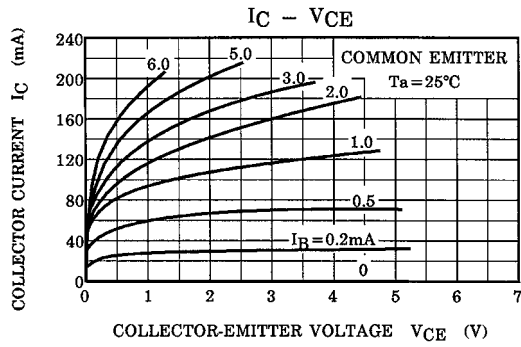
Fig.1 : Reverse Recovery Time ( $t_{rr}$ ) Test Circuit



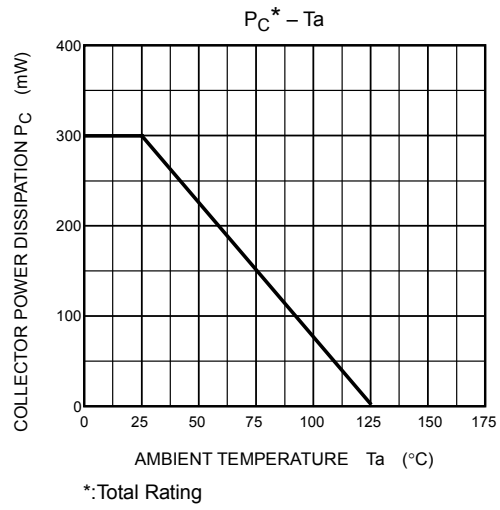
Q1



Q2



## Q1,Q2 Common



**RESTRICTIONS ON PRODUCT USE**

030619EAA

- The information contained herein is subject to change without notice.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of TOSHIBA or others.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.  
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- TOSHIBA products should not be embedded to the downstream products which are prohibited to be produced and sold, under any law and regulations.